

Notice of References Cited	Application/Control No. 10/665,028		Applicant(s)/Patent Under Reexamination HU, YIPING	
	Examiner Samuel M. Heinrich		Art Unit 1725	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,749,878	07-1973	Sullivan et al.	219/121.67
*	B	US-H389	12-1987	Moon	372/58
*	C	US-4,782,496	11-1988	Couturier, Donald I.	219/121.63
*	D	US-20040099643	05-2004	Fabbro et al	219/63
*	E	US-6696664	02-2004	Pyriz et al	219/121.64
*	F	US-6534745	03-2003	Lowney	219/121.84
*	G	US-6,316,744	11-2001	Nowotny et al.	219/121.84
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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